

# L4: Sequential Building Blocks

## (Flip-flops, Latches and Registers)

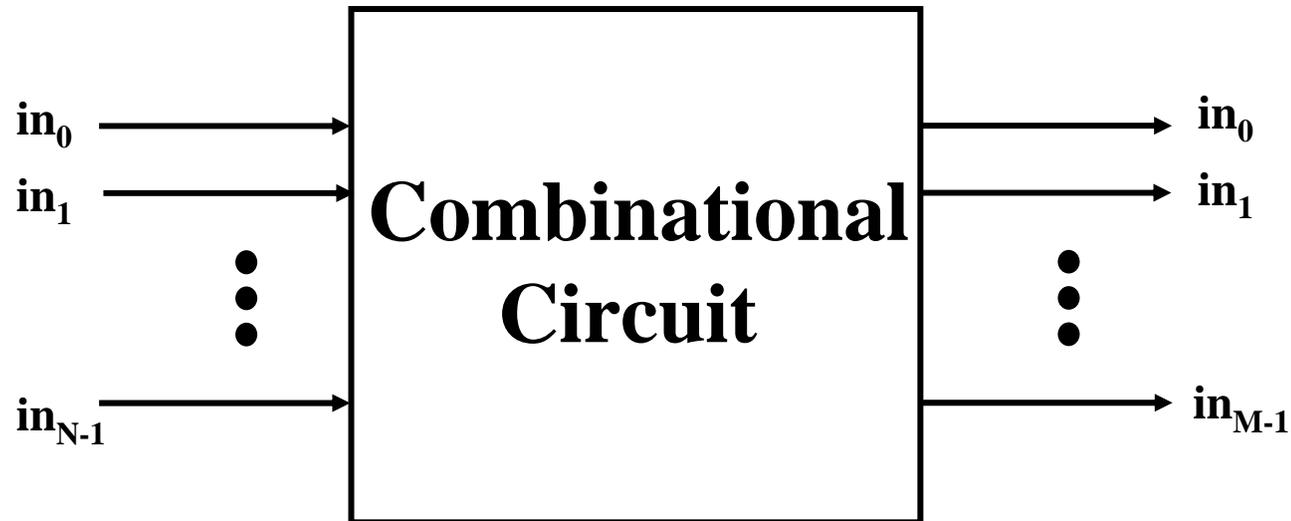


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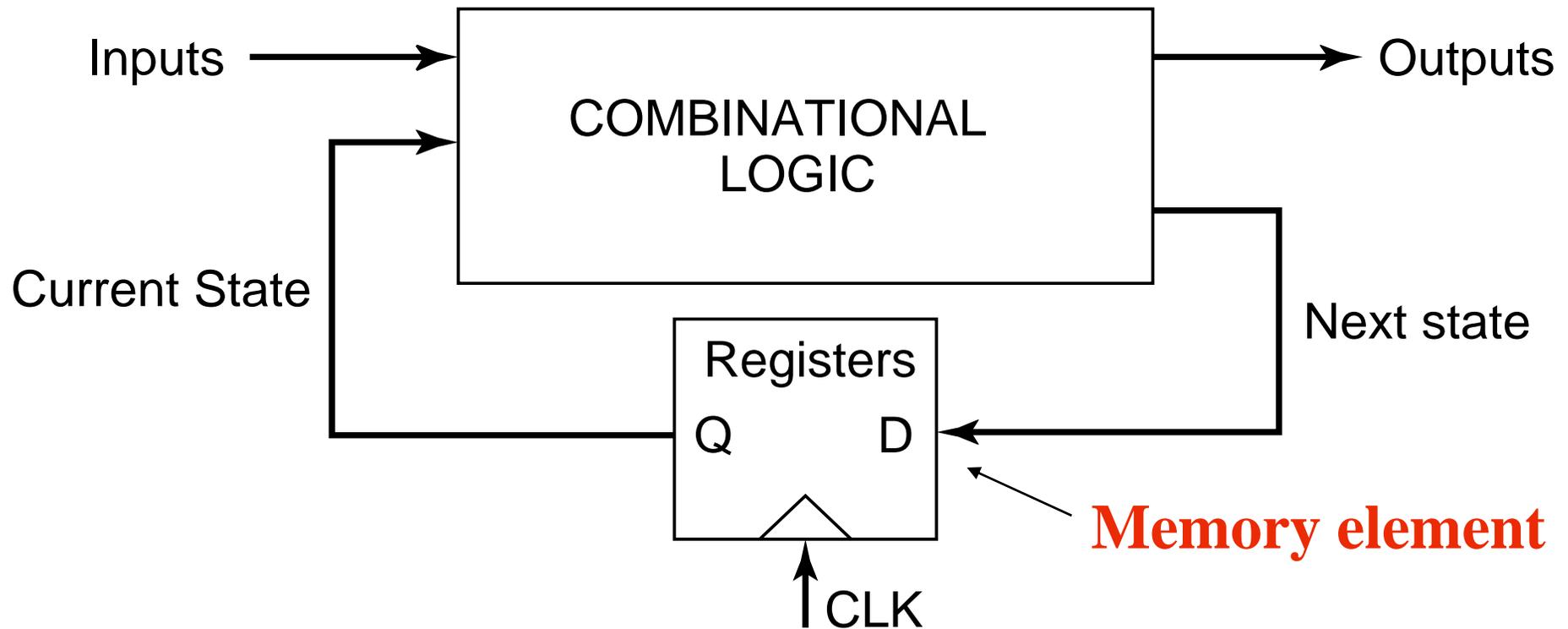
### Acknowledgements:

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- Randy H. Katz (University of California, Berkeley, Department of Electrical Engineering & Computer Science)
- Gaetano Borriello (University of Washington, Department of Computer Science & Engineering, <http://www.cs.washington.edu/370>)
- Rabaey, A. Chandrakasan, B. Nikolic. *Digital Integrated Circuits: A Design Perspective*. Prentice Hall, 2003.

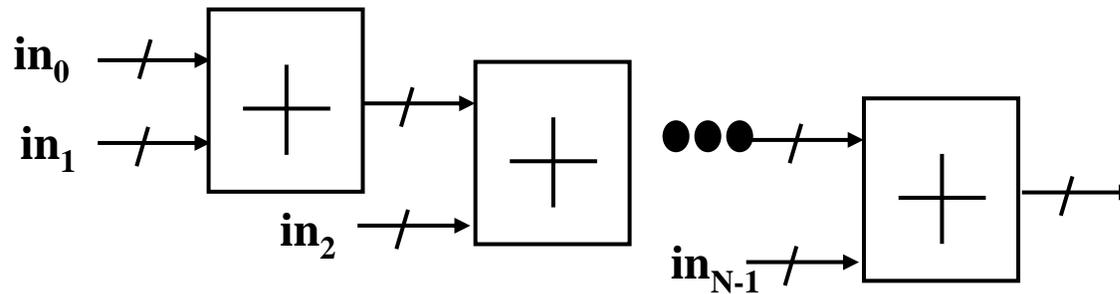


- **Combinational logic circuits are memoryless**
- **No feedback in combinational logic circuits**
- **Output assumes the function implemented by the logic network, assuming that the switching transients have settled**
- **Outputs can have multiple logical transitions before settling to the correct value**

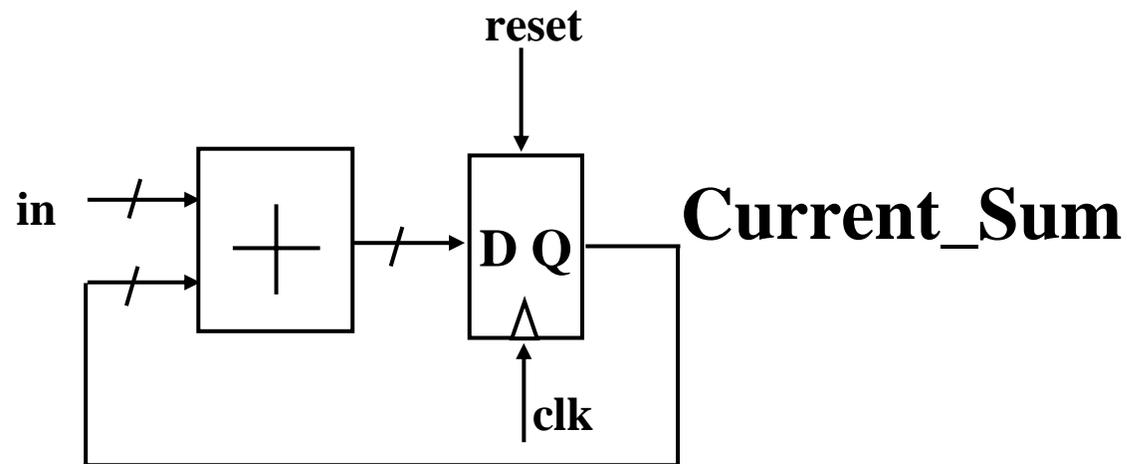


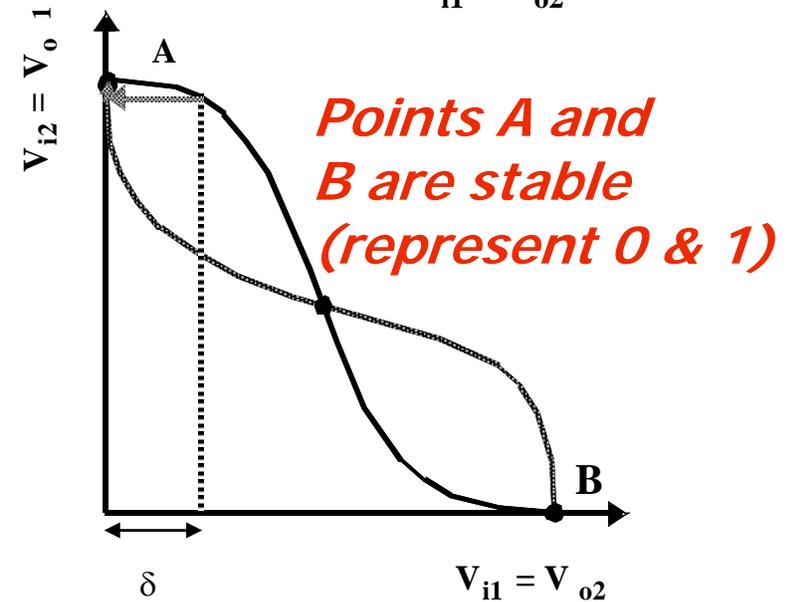
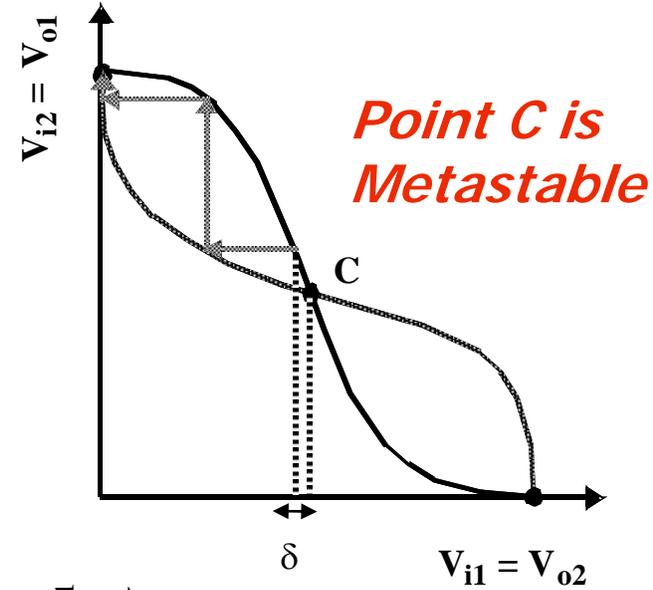
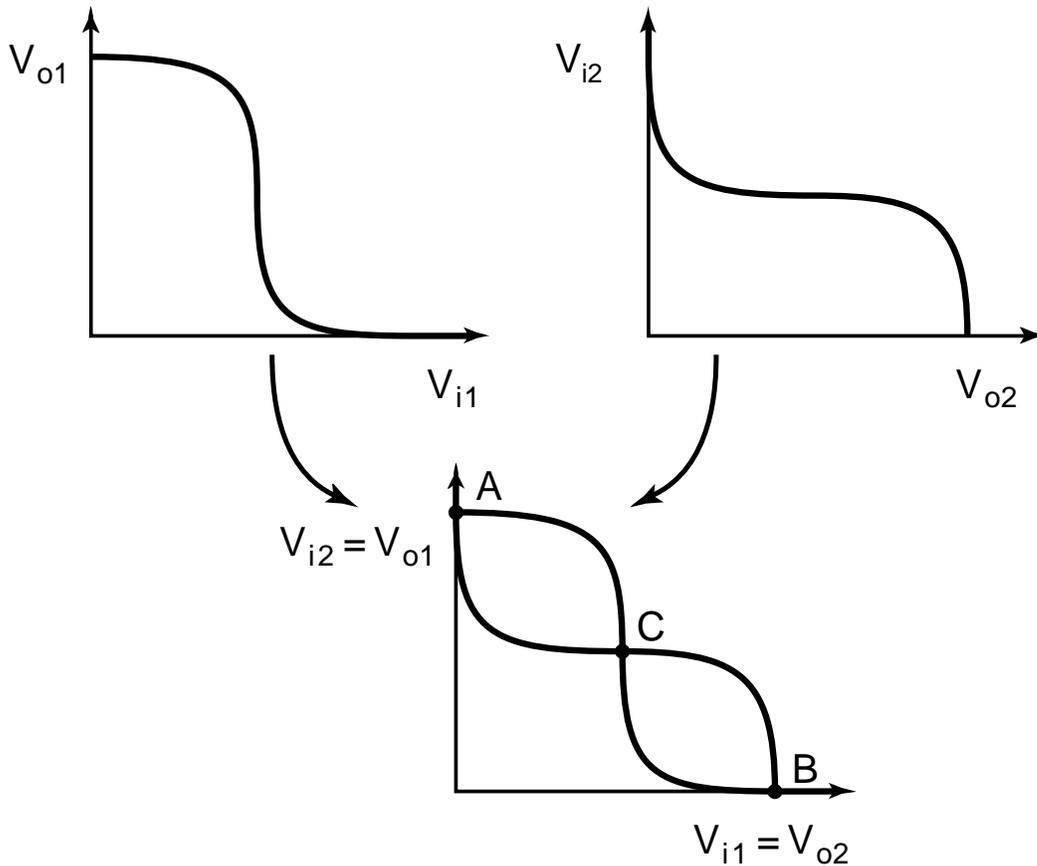
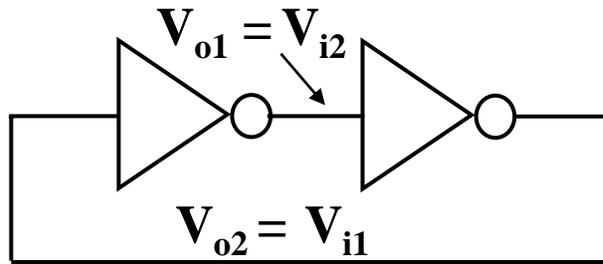
- **Sequential circuits have memory (i.e., remember the past)**
- **The current state is “held” in memory and the next state is computed based the current state and the current inputs**
- **In a synchronous systems, the **clock signal** orchestrates the sequence of events**

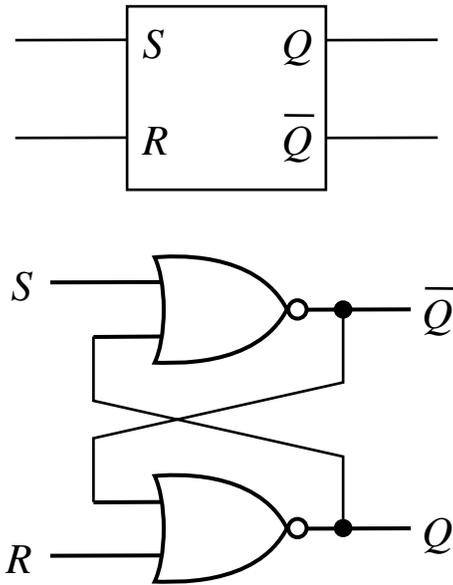
## Adding N inputs (N-1 Adders)



## Using a sequential (serial) approach

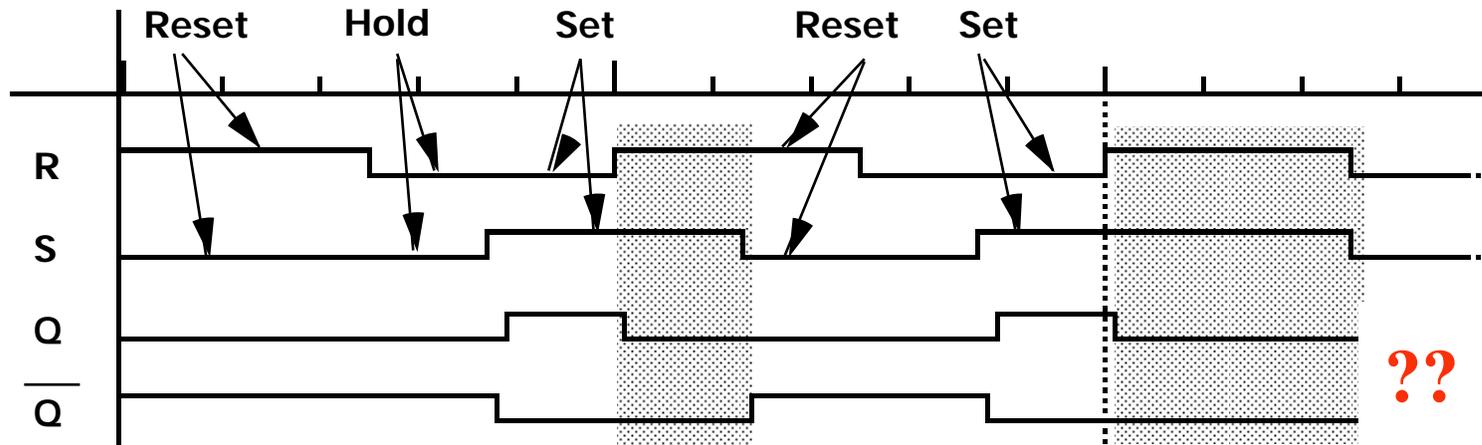
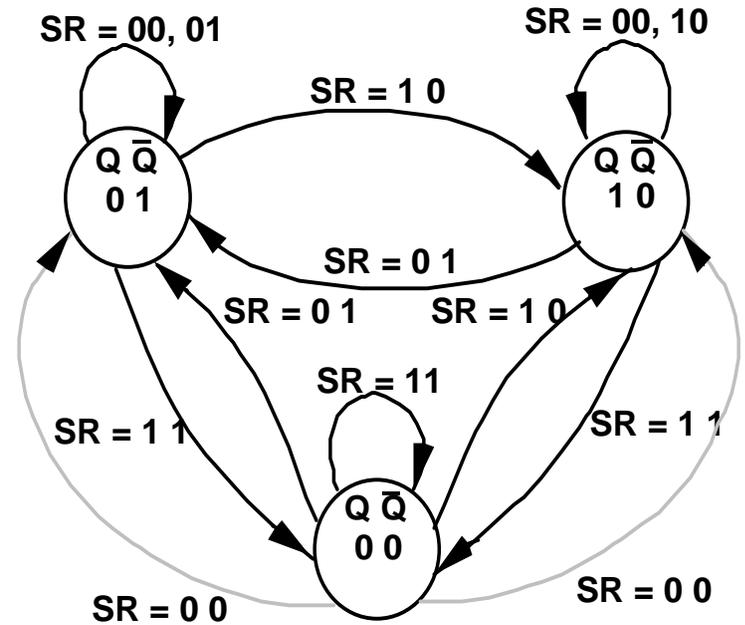






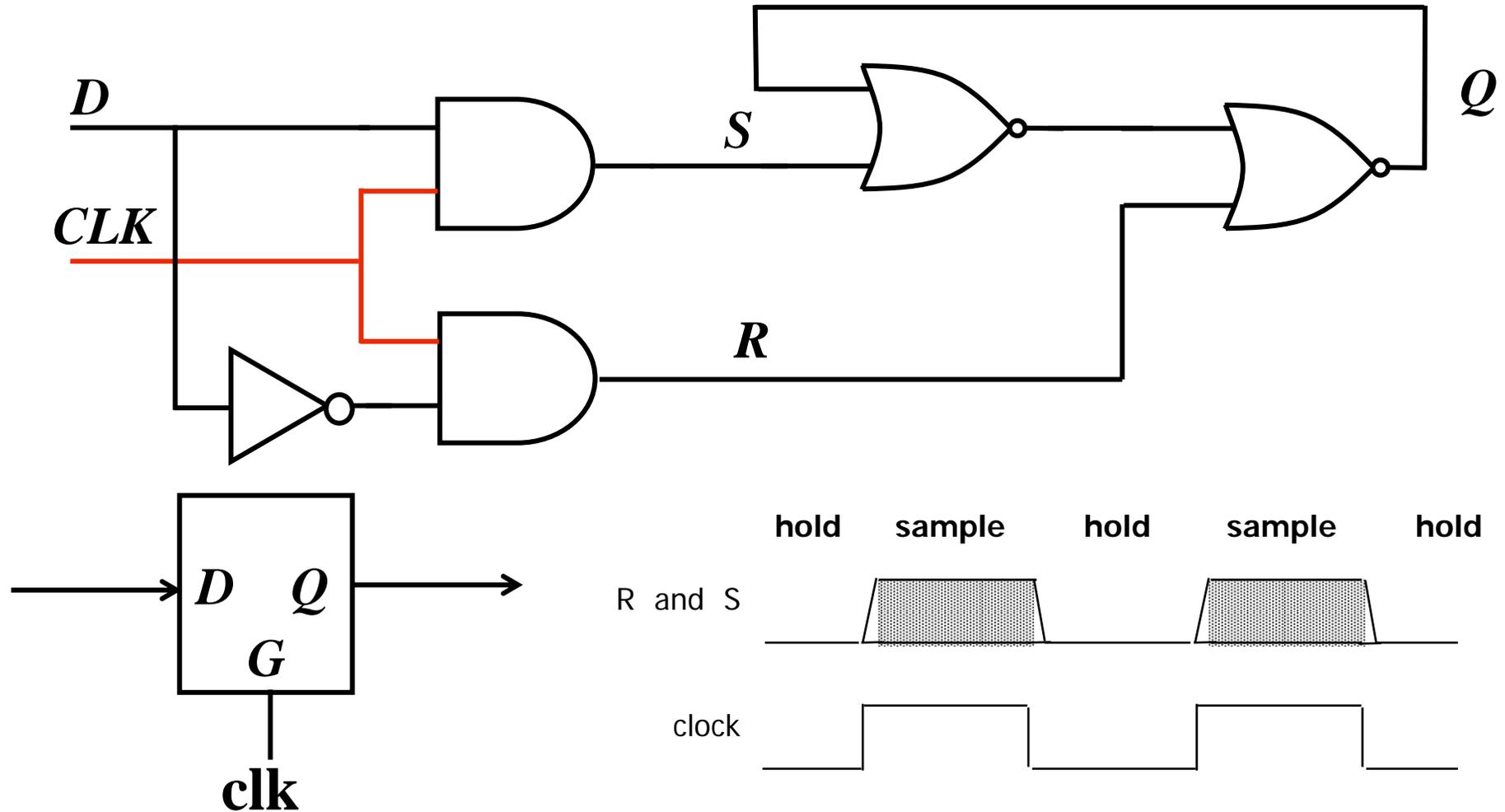
$S$	$R$	$Q$	$\bar{Q}$
0	0	$Q$	$\bar{Q}$
1	0	1	0
0	1	0	1
1	1	0	0

Forbidden State



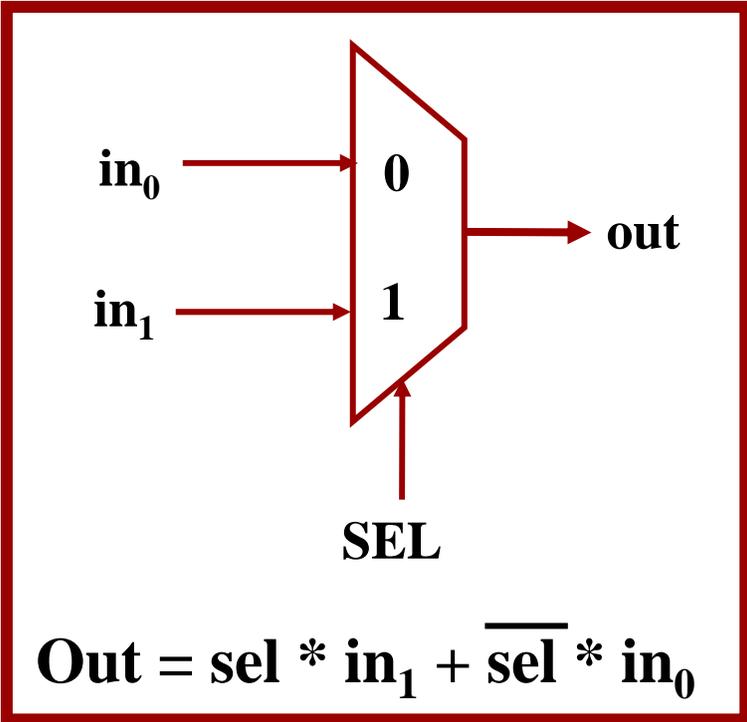
- Flip-flop refers to a bi-stable element (edge-triggered registers are also called flip-flops) – this circuit is not clocked and outputs change “asynchronously” with the inputs

# Making a Clocked Memory Element: Positive D-Latch

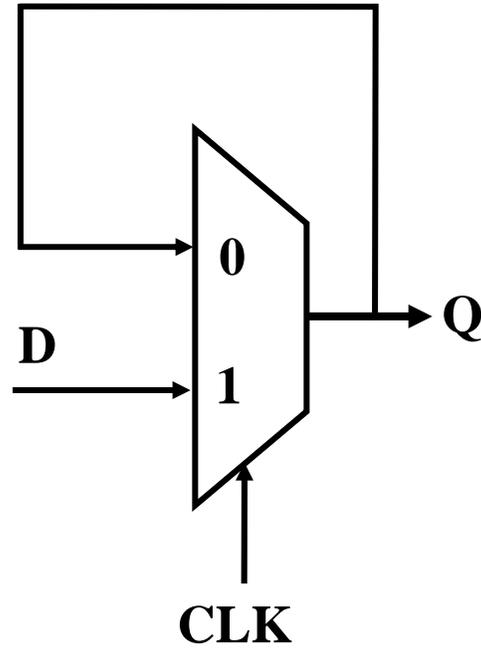


- **A Positive D-Latch:** Passes input  $D$  to output  $Q$  when  $CLK$  is high and holds state when clock is low (i.e., ignores input  $D$ )
- **A Latch is level-sensitive:** invert clock for a negative latch

### 2:1 multiplexor



### Positive Latch



### Negative Latch

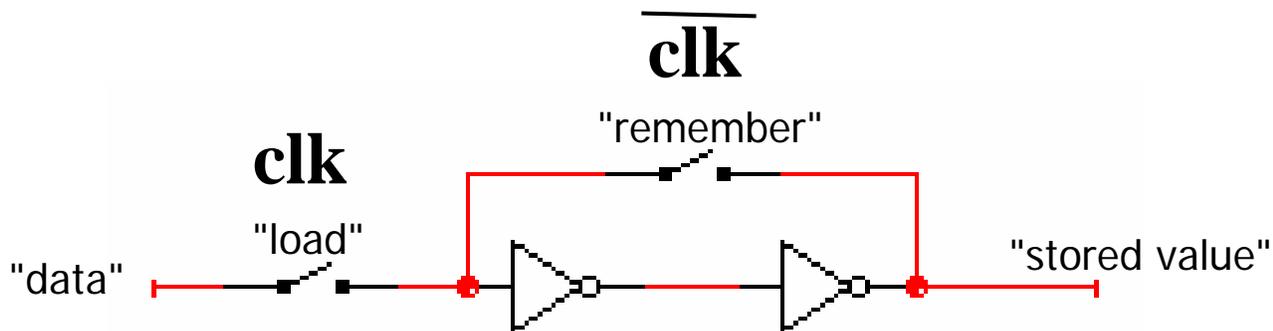
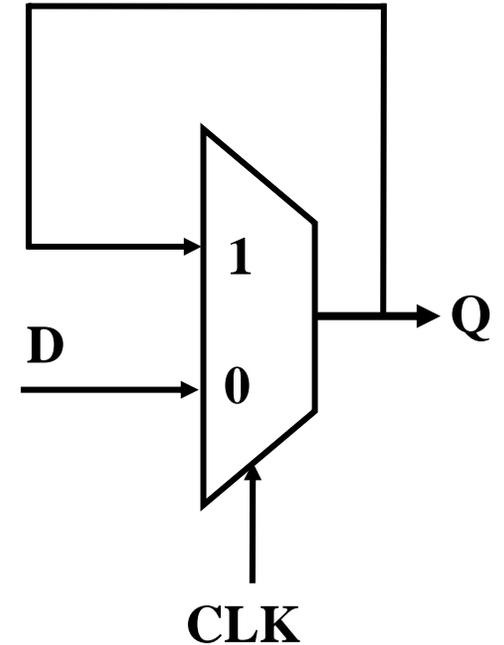
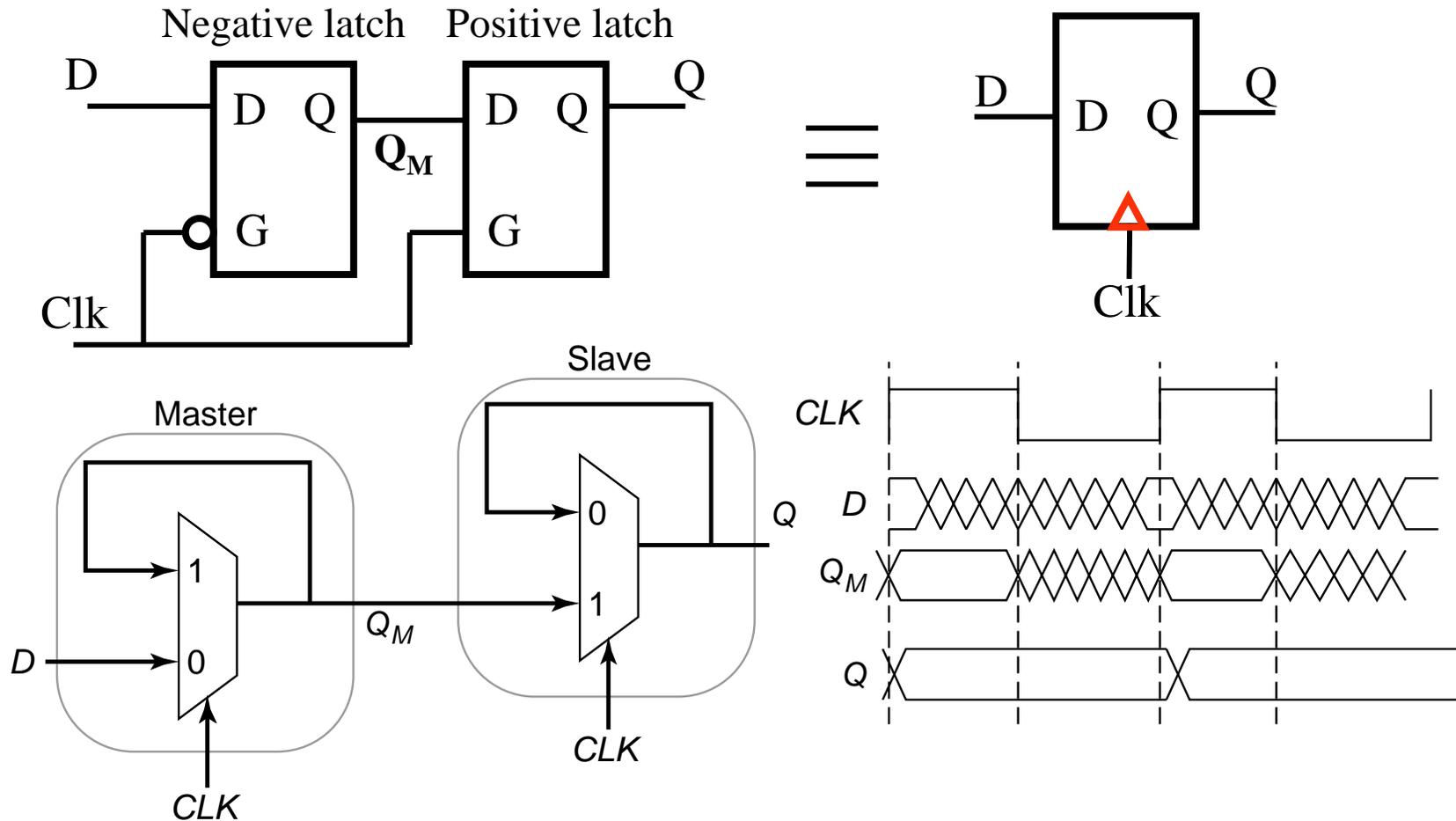


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OPERATING MODES	INPUTS		OUTPUTS	
	$LE_{n-n}$	nD	nQ	$n\bar{Q}$
data enabled	H	L	L	H
	H	H	H	L
data latched	L	X	q	$\bar{q}$



## ■ Master-Slave Register

- Use negative clock phase to latch inputs into first latch
- Use positive clock to change outputs with second latch

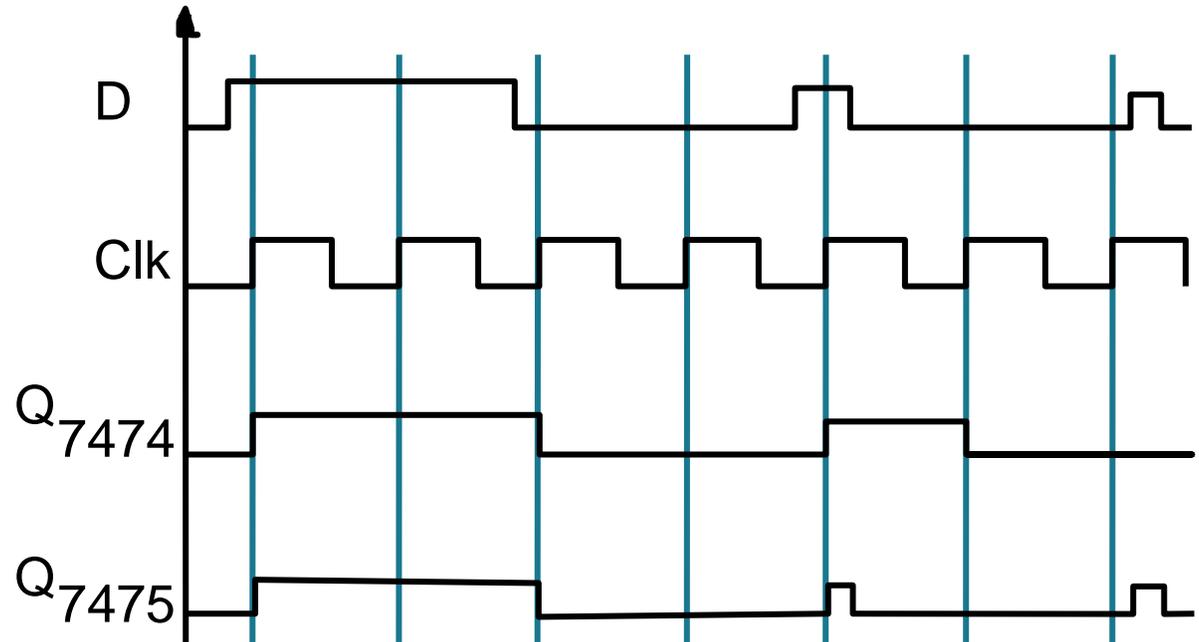
## ■ View pair as one basic unit

- master-slave flip-flop twice as much logic

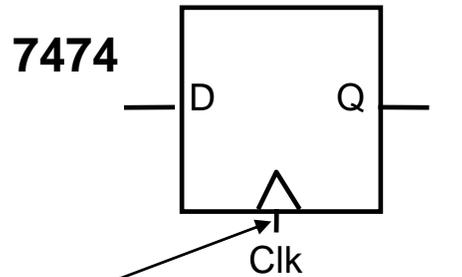
*Edge triggered* device sample inputs on the event edge

*Transparent latches* sample inputs as long as the clock is asserted

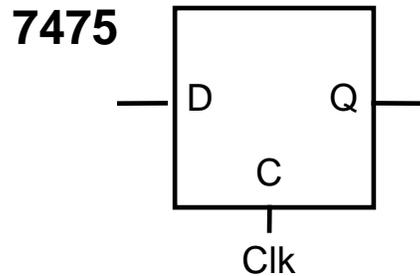
Timing Diagram:



*Behavior the same unless input changes while the clock is high*

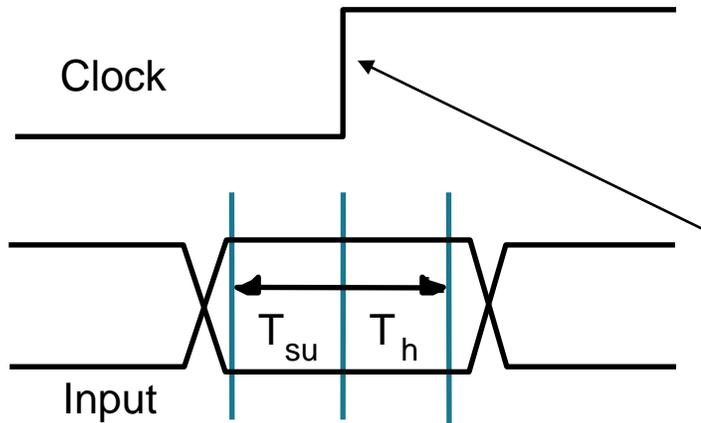


Positive edge-triggered register



Level-sensitive latch

**Bubble here for negative edge triggered register**



***Clock:***

Periodic Event, causes state of memory element to change

memory element can be updated on the: rising edge, falling edge, high level, low level

***Setup Time ( $T_{su}$ )***

Minimum time before the clocking event by which the input must be stable

***Hold Time ( $T_h$ )***

Minimum time after the clocking event during which the input must remain stable

***Propagation Delay ( $T_{cq}$  for an edge-triggered register and  $T_{dq}$  for a latch)***

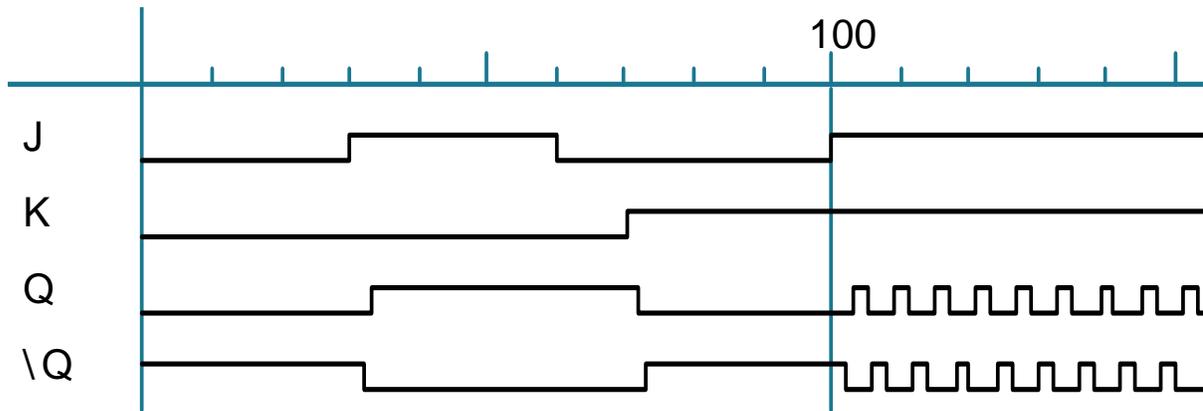
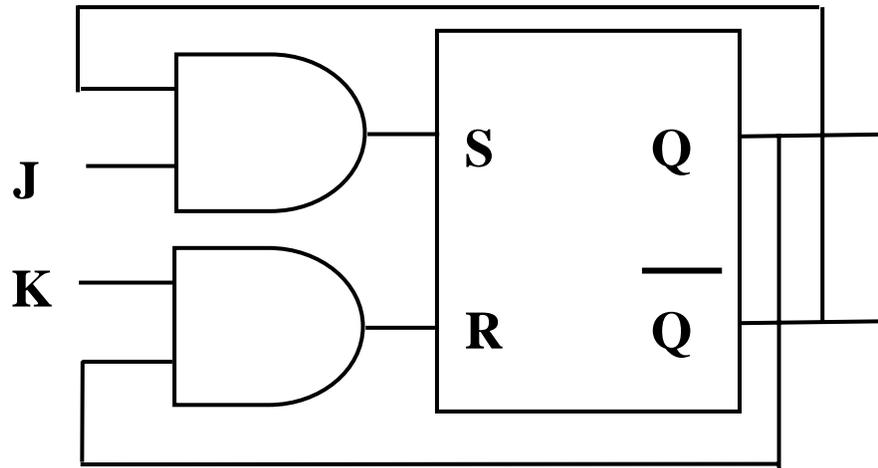
Delay overhead of the memory element

There is a timing "window" around the clocking event during which the input must remain stable and unchanged in order to be recognized

# 74HC74 (Positive Edge-Triggered Register)

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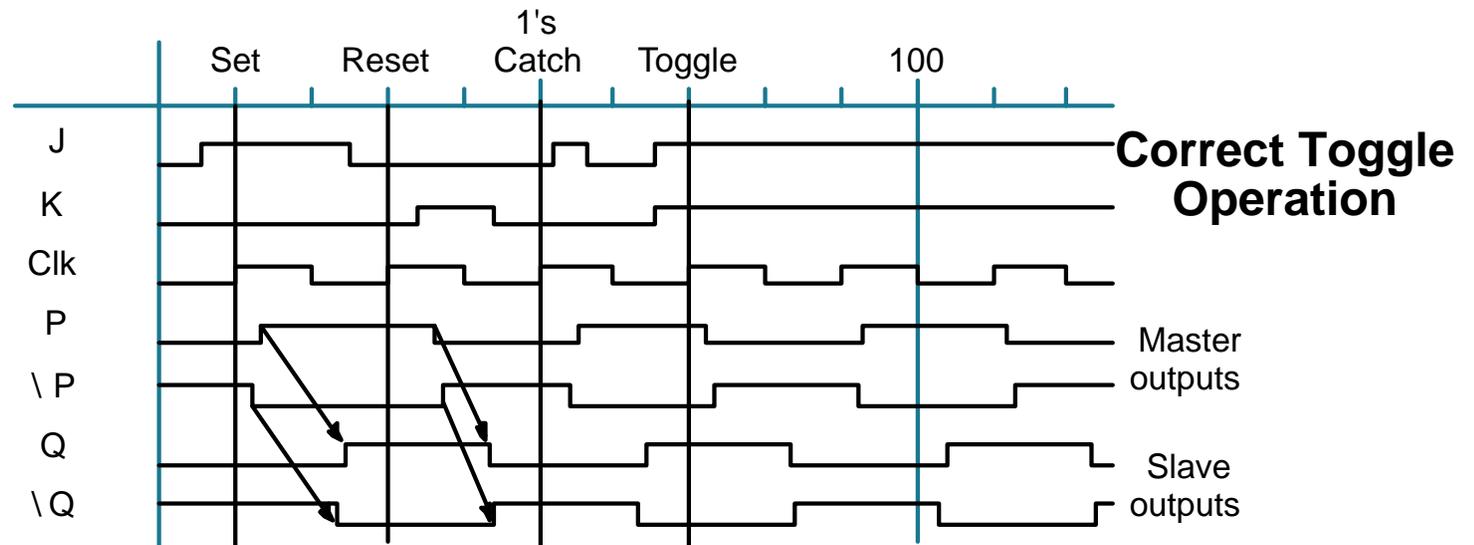
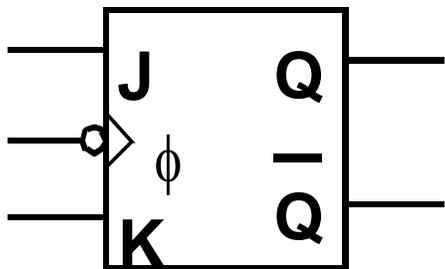
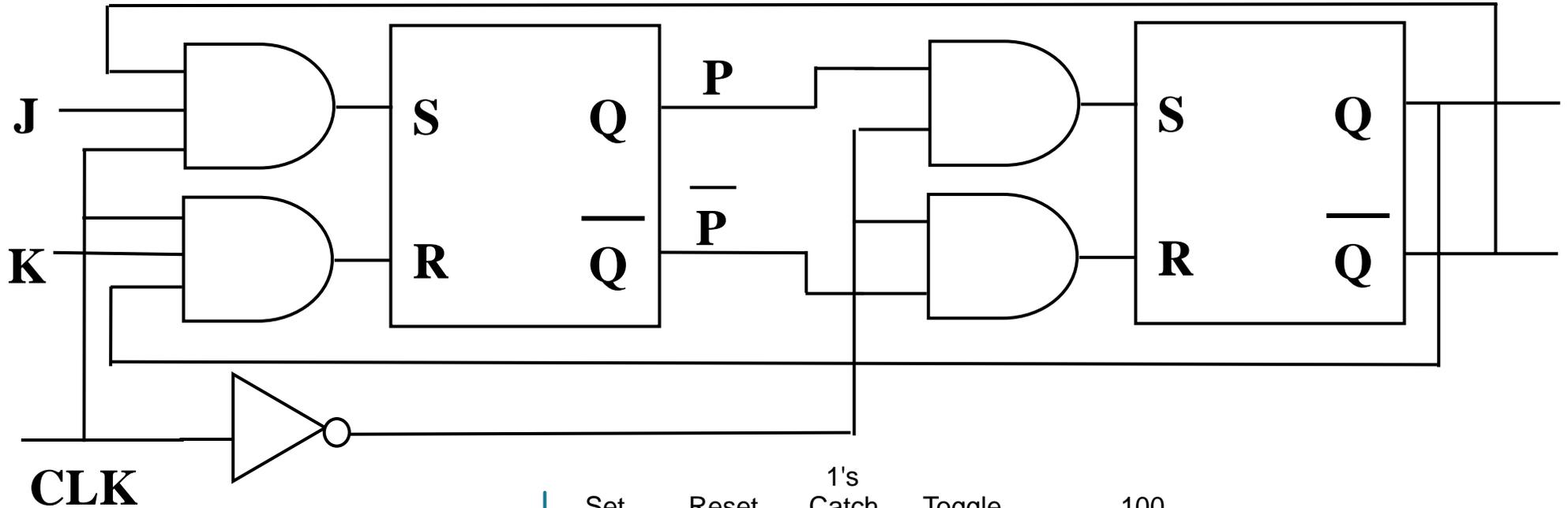


J	K	Q <sub>+</sub>	$\overline{Q}_+$
0	0	Q	$\overline{Q}$
0	1	0	1
1	0	1	0
1	1	$\overline{Q}$	Q

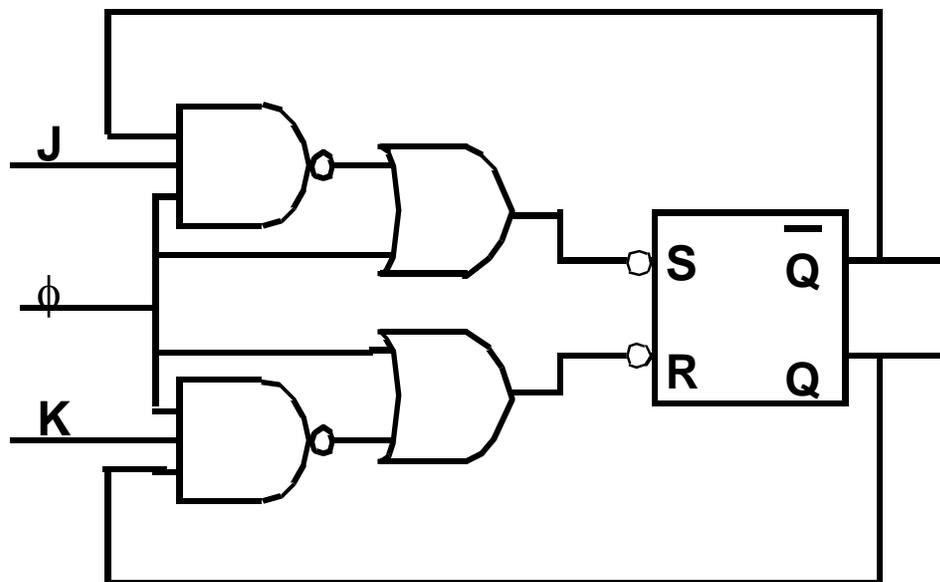
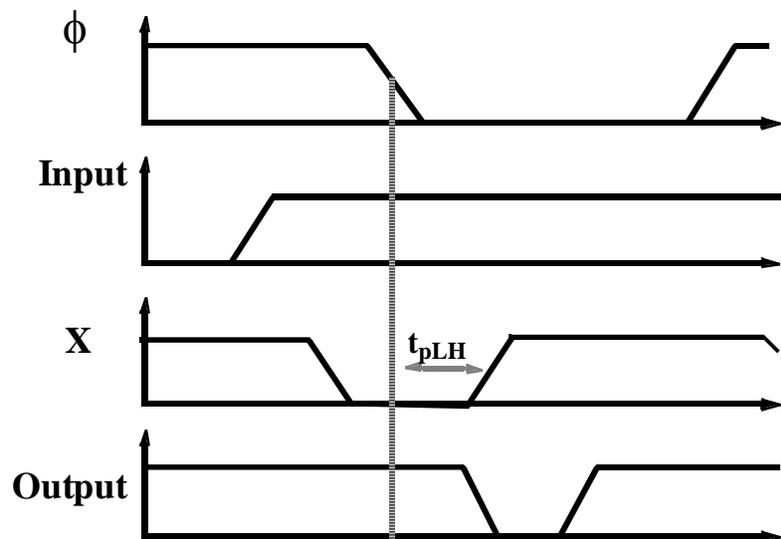
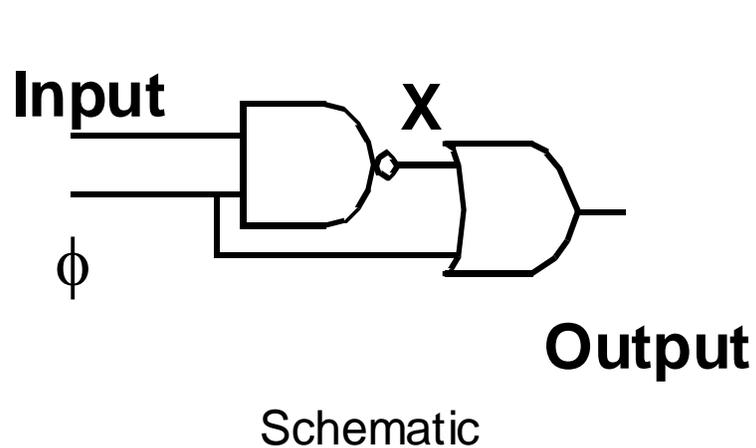
- Eliminate the forbidden state of the SR Flip-flop
- Use output feedback to guarantee that R and S are never both one

Sample inputs while clock high

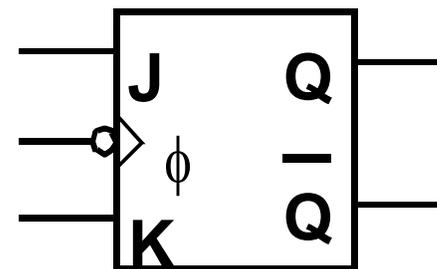
Sample inputs while clock low



**Is there a problem with this circuit?**



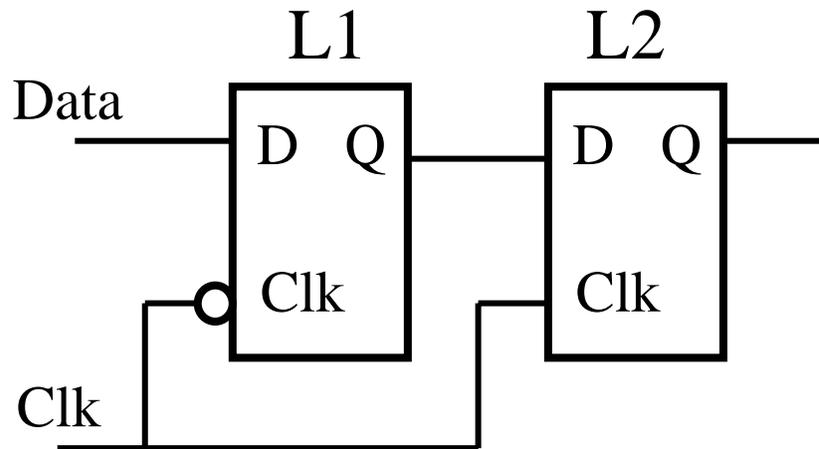
JK Register Schematic



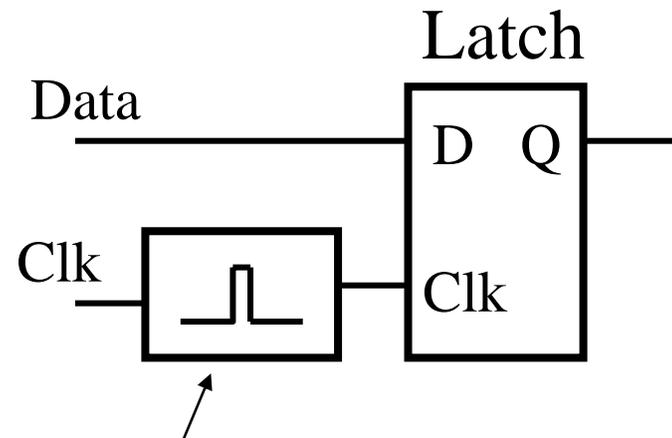
JK Register Logic Symbol

Ways to design an edge-triggered sequential cell:

## Master-Slave Latches

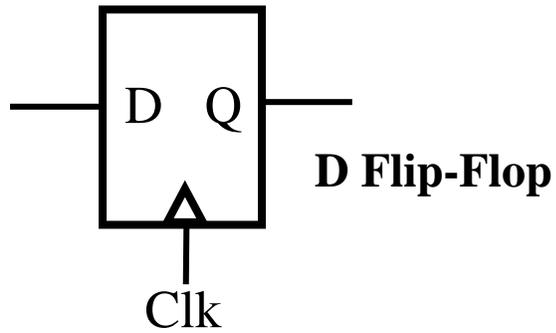


## Pulse-Based Register

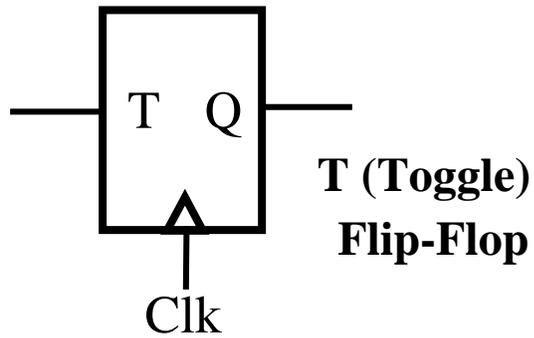
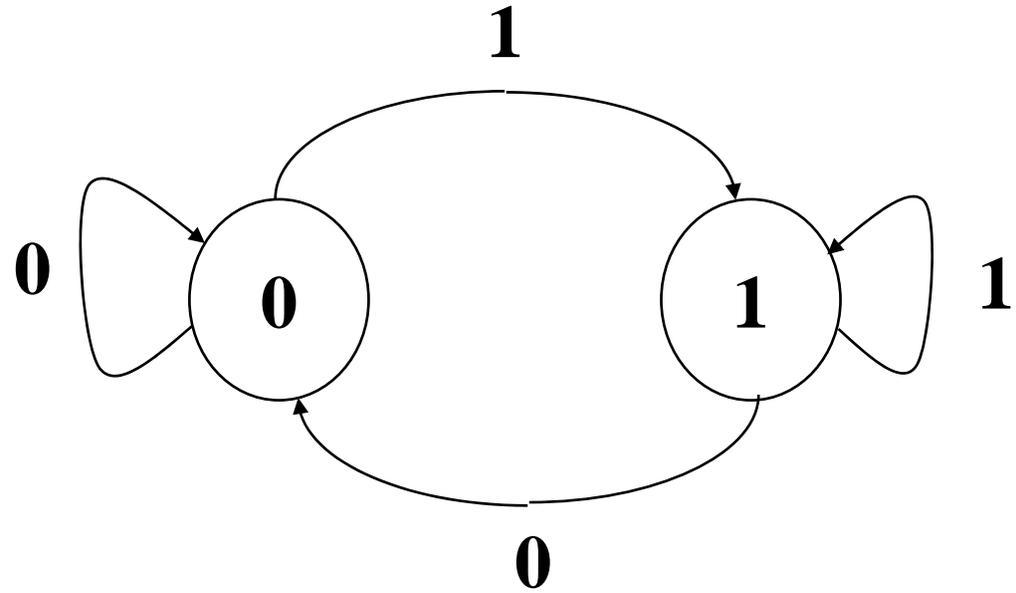


**Short pulse around clock edge**

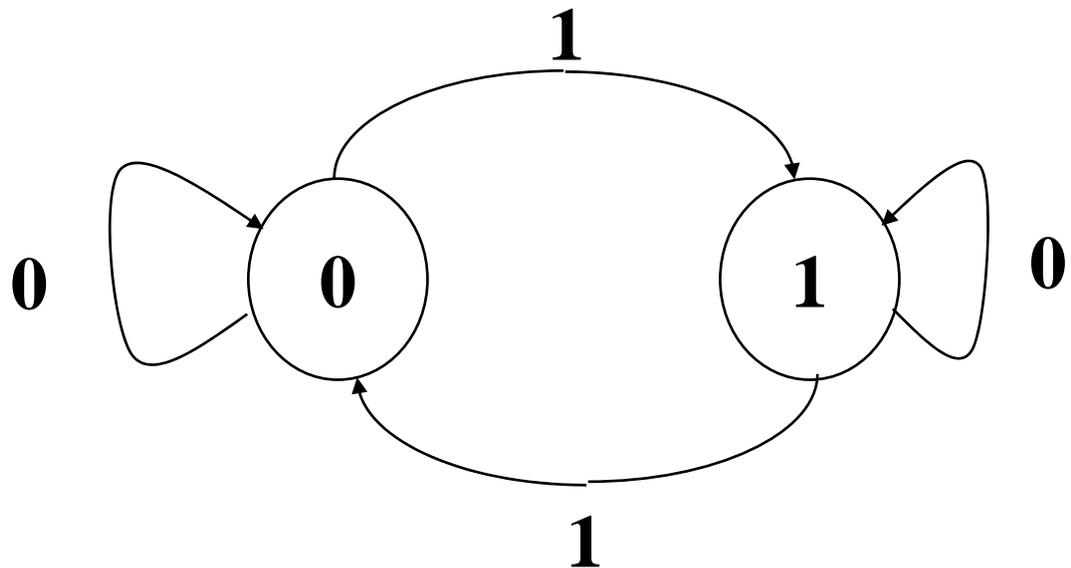
- **Pulse registers are widely used in high-performance microprocessor chips (Sun Microsystems, AMD, Intel, etc.)**
- **The can have a negative setup time!**



D	$Q_N$
0	0
1	1



T	$Q_N$
0	$Q_{N-1}$
1	$\overline{Q_{N-1}}$



## Characteristic Equations

D:  $Q_+ = D$

J-K:  $Q_+ = J \bar{Q} + \bar{K} Q$

T:  $Q_+ = T \bar{Q} + \bar{T} Q$

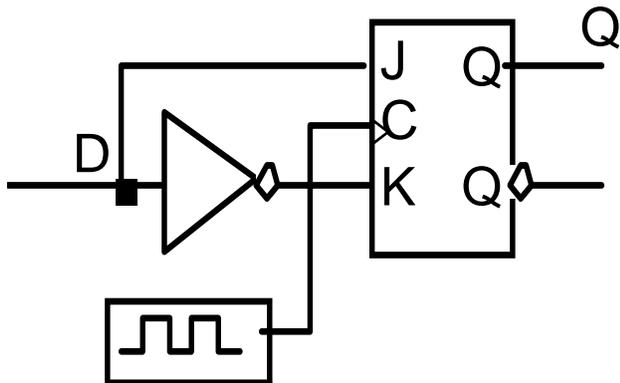
E.g., J=K=0, then  $Q_+ = Q$

J=1, K=0, then  $Q_+ = 1$

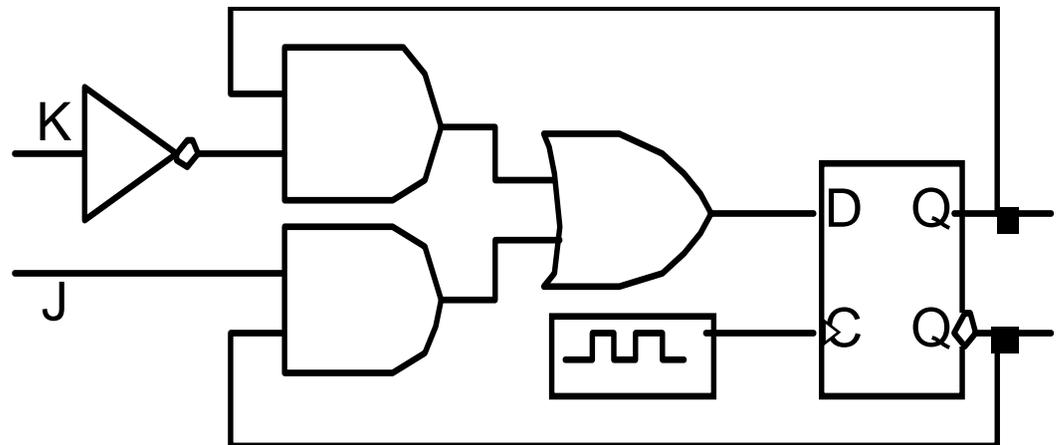
J=0, K=1, then  $Q_+ = \bar{Q}$

J=1, K=1, then  $Q_+ = \bar{Q}$

## Implementing One FF in Terms of Another



D implemented with J-K



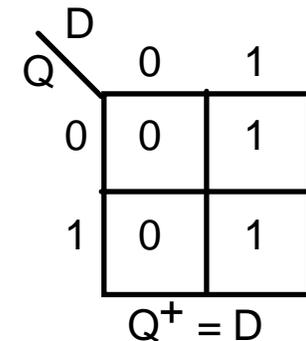
J-K implemented with D

**Excitation Tables:** What are the necessary inputs to cause a particular kind of change in state?

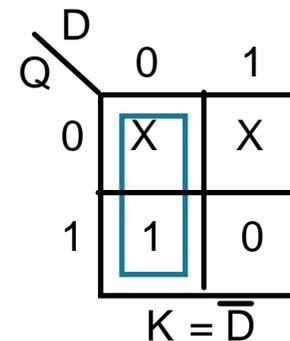
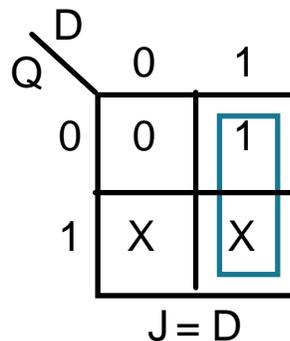
Q	Q+	J	K	T	D
0	0	0	X	0	0
0	1	1	X	1	1
1	0	X	1	1	0
1	1	X	0	0	1

**Implementing D FF with a J-K FF:**

- 1) Start with K-map of  $Q^+ = f(D, Q)$
- 2) Create K-maps for J and K with same inputs (D, Q)
- 3) Fill in K-maps with appropriate values for J and K to cause the same state changes as in the original K-map



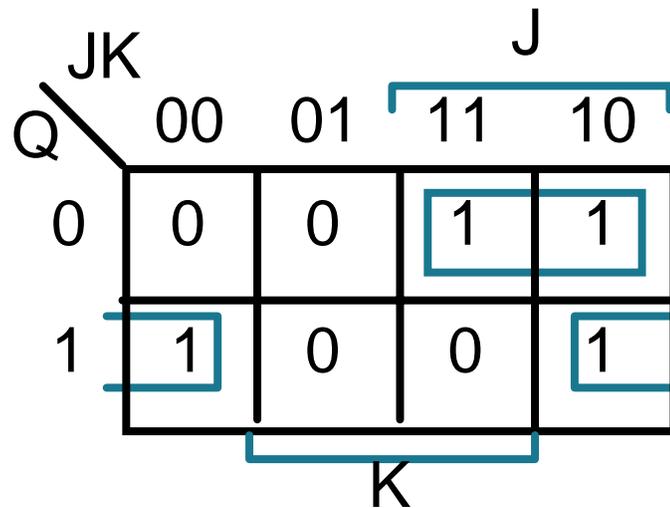
E.g.,  $D = Q = 0$ ,  $Q^+ = 0$   
then  $J = 0$ ,  $K = X$



Implementing J-K FF with a D FF:

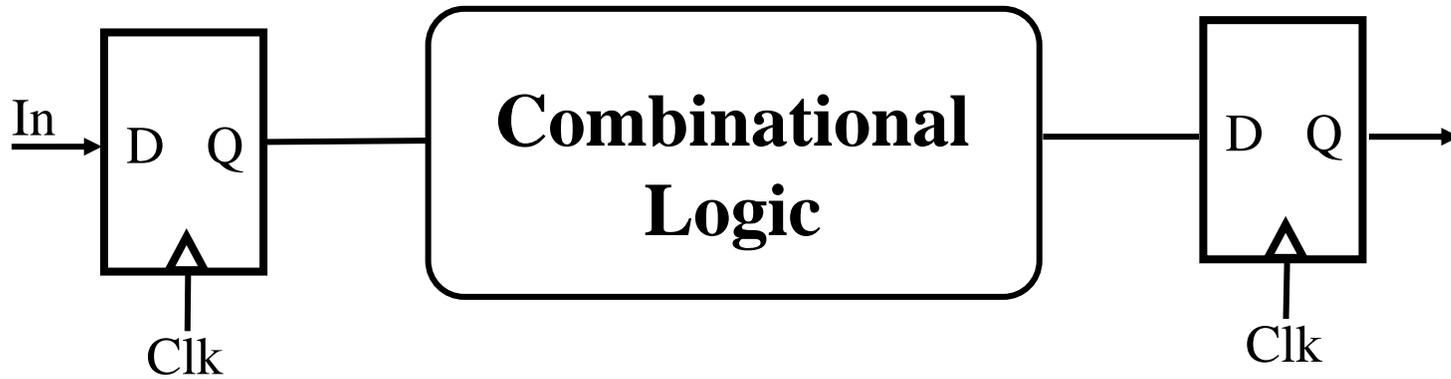
1) K-Map of  $Q^+ = F(J, K, Q)$

2,3) Revised K-map using D's excitation table  
 its the same! that is why design procedure with D FF is simple!



$$Q^+ = D = J\bar{Q} + \bar{K}Q$$

Resulting equation is the combinational logic input to D to cause same behavior as J-K FF. Of course it is identical to the characteristic equation for a J-K FF.



## Register Timing Parameters

$T_{cq}$  : worst case rising edge  
clock to q delay

$T_{cq, cd}$  : contamination or  
minimum delay from  
clock to q

$T_{su}$  : setup time

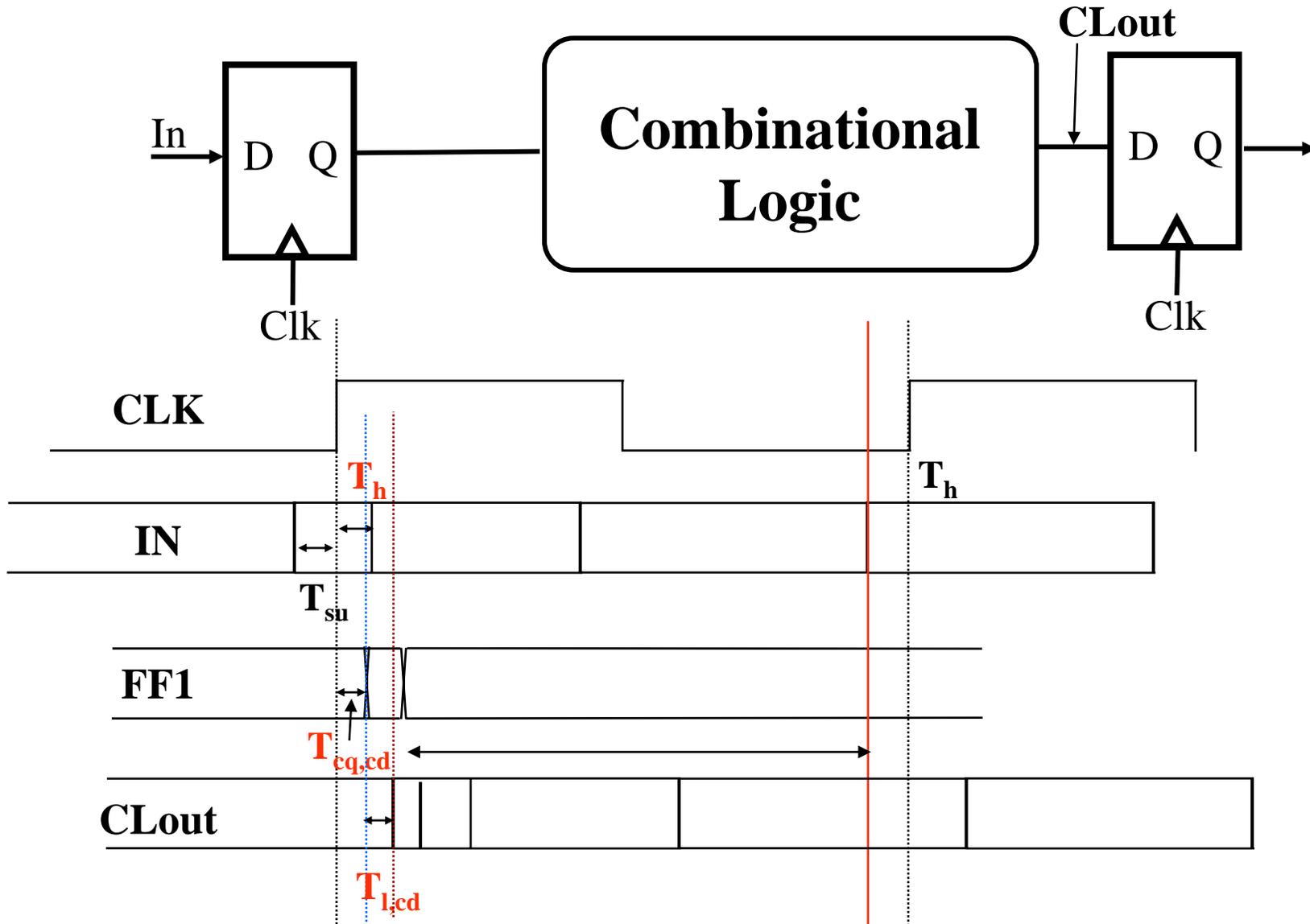
$T_h$  : hold time

## Logic Timing Parameters

$T_{logic}$  : worst case delay  
through the combinational  
logic network

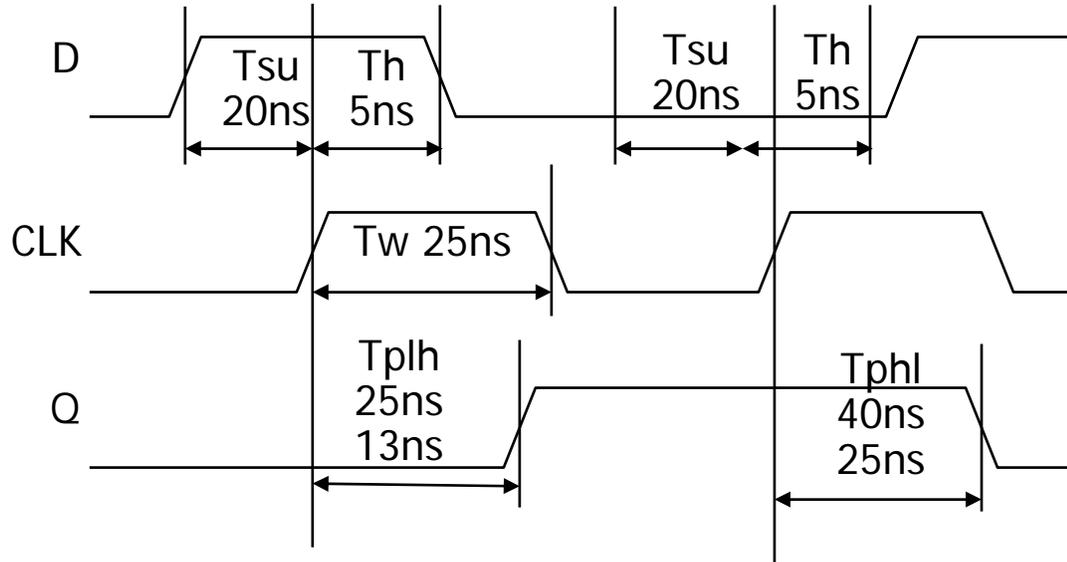
$T_{logic, cd}$  : contamination or  
minimum delay  
through logic network





$$T_{cq,cd} + T_{logic,cd} > T_{hold}$$

## ■ Typical parameters for Positive edge-triggered D Register



all measurements are made from the clocking event that is, the rising edge of the clock

## ■ Shift-register

